

Use of IQI Standard – a tentative way forward in NDI of AM parts?

WG2 Break-out session: FDT and NDI of AM parts (EASA FAA Industry-Regulator AM Event)

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Experience in certification expectation and key technology blockers ...

Experience in certification expectation:

- In-house activities to provide sufficient substantiation taking much longer (and costs) than expected

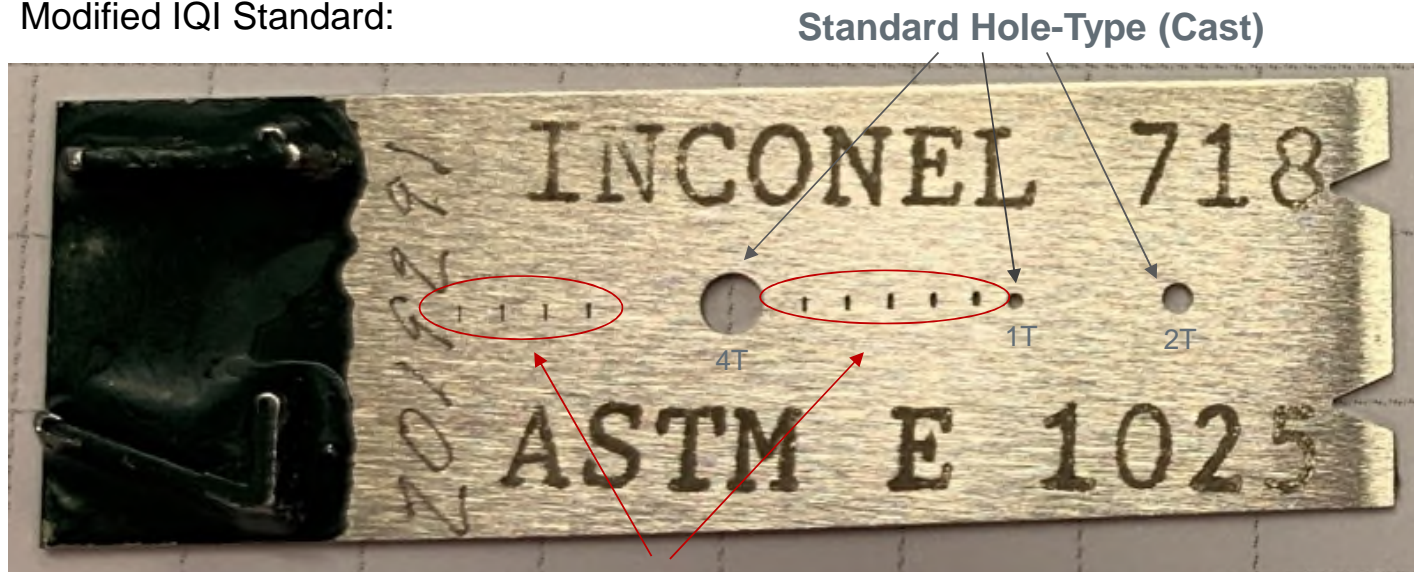
key technology blockers:

- **Process complexity/material variation - dependent on associated AM process parameters/parts geometry**
 - amongst others: ***LackOfFusion defects of concern***, occurrence rate depending on process parameters/machine and difficult to detect by NDI, random occurrence related to inherent process 'disturbances'
- **Parts quality substantiation strategy – business case critical**
 - Beneficial HIP impact on defects and μ -structure homogenization to improve quality of AM part
 - ***NDI costs (depending on parts criticality):*** LOF defects: sizes/frequency of occurrence and detectability
→ ***CT – “Gold Standard” – application critical on large Ni-components w.r.t. detectability / cost***
 - Combined NDI, FAI, process control vs. (allowable) defect size used in the analytical substantiation (design lines and/or damage tolerance)
 - **Concern/Q: → 'largest flaw size' which can be missed?**

Starting Point: Image Quality Indicator (IQI) Standard for Radiography

ASTM-E1025 - 18: Standard Practice for Design, Manufacture, and Material Grouping Classification of Hole-Type Image Quality Indicators (IQI) Used for Radiography

Modified IQI Standard:



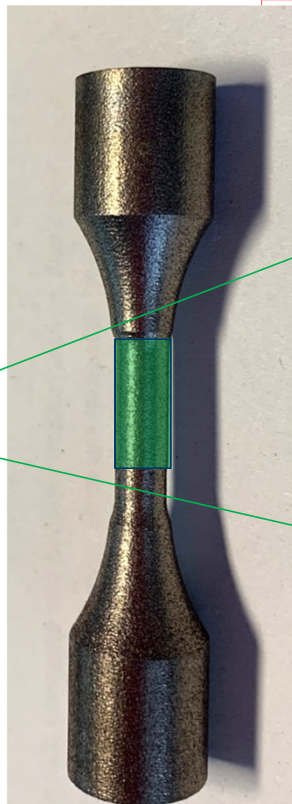
Innovative Cuboid-Type (AM)

Modified IQI Standard for cast alloys with characteristic AM-Defects (LOF)

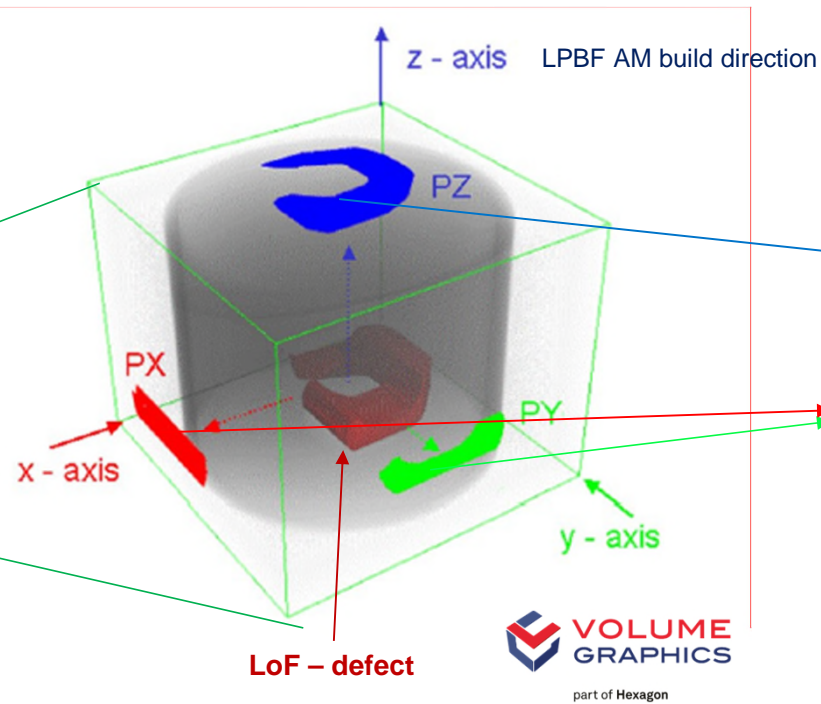
Dimensional characterization of AM LOF defects using CT...



V|tome|xs 240



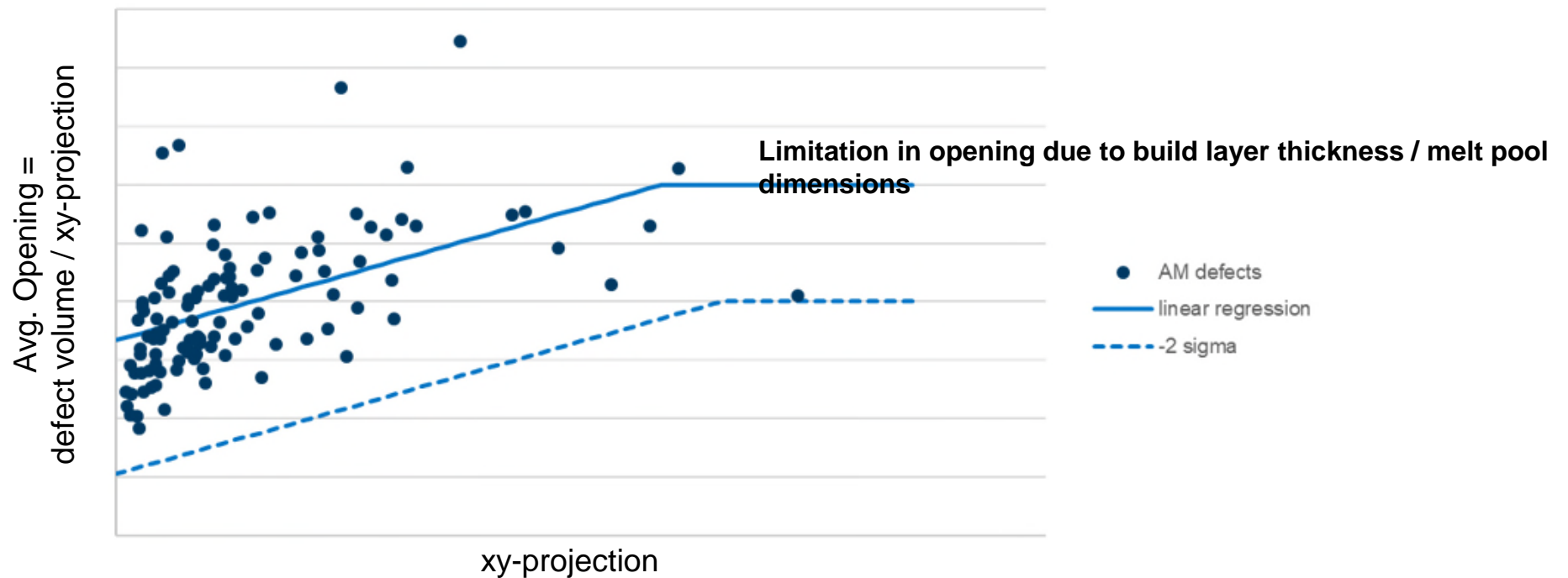
specimen with low energy process parameter
(intentionally induced AM defects → LOF)



xy-projection

Avg. Opening =
defect volume / xy-projection

Dimensional characterization of AM LOF defects ...

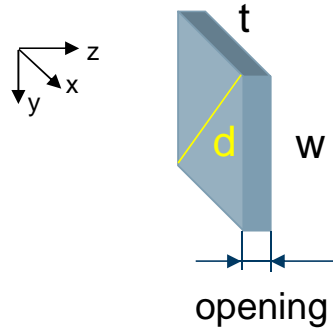


Linear Regression of avg. opening AM defects vs. area projection and limitation due to layer thickness

Cuboid-Type → Modified IQI

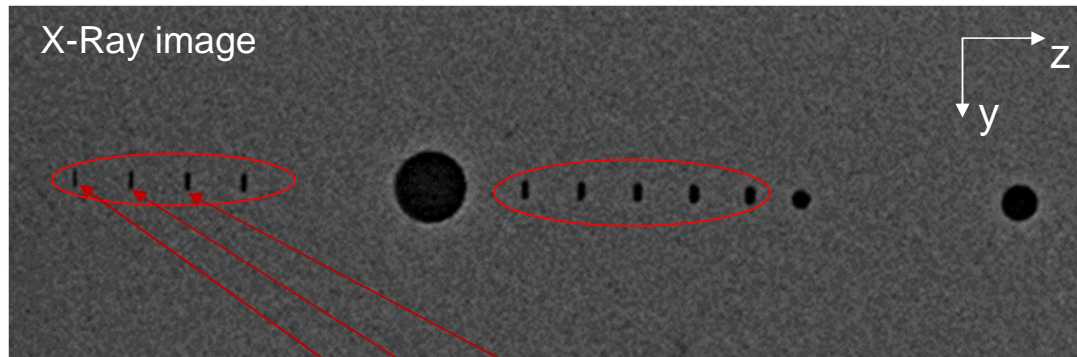
Definition cuboid-type:

IQI wall thickness t = width w



Laser cutting → Modified IQI (ASTM-E-1025)
Various IQIs dependent on different wall thickness

IQI used on AM step plate with step thickness representative for part thickness

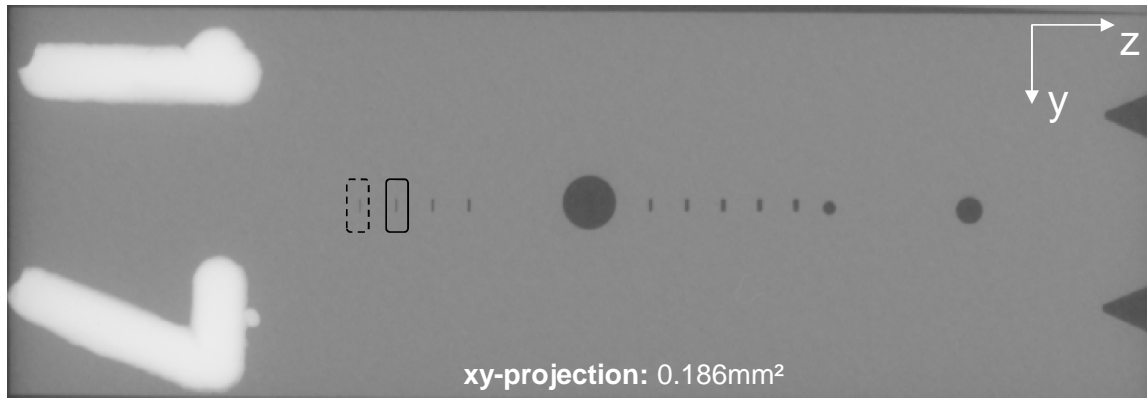


Cuboid slot (opening) → 40 μ m, 60 μ m, 80 μ m, +20 μ m...

Cuboid-Type derived from linear regression (avg. opening vs. xy-projection)

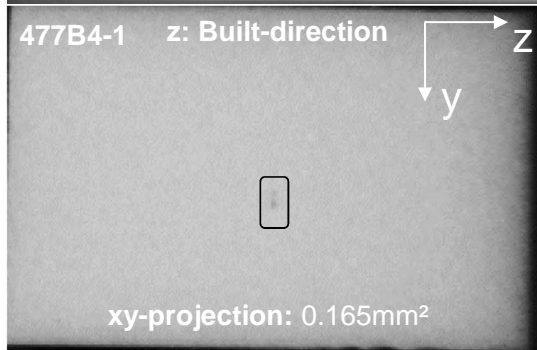
Cuboid - Type vs “real” AM defect

2D film X-Ray:

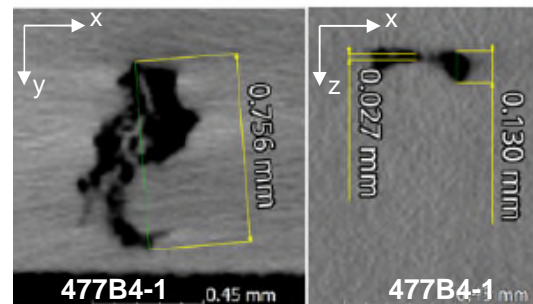


opening: 0.060mm (confirmation with 0.040mm)

xy-projection: 0.186mm²



CT:

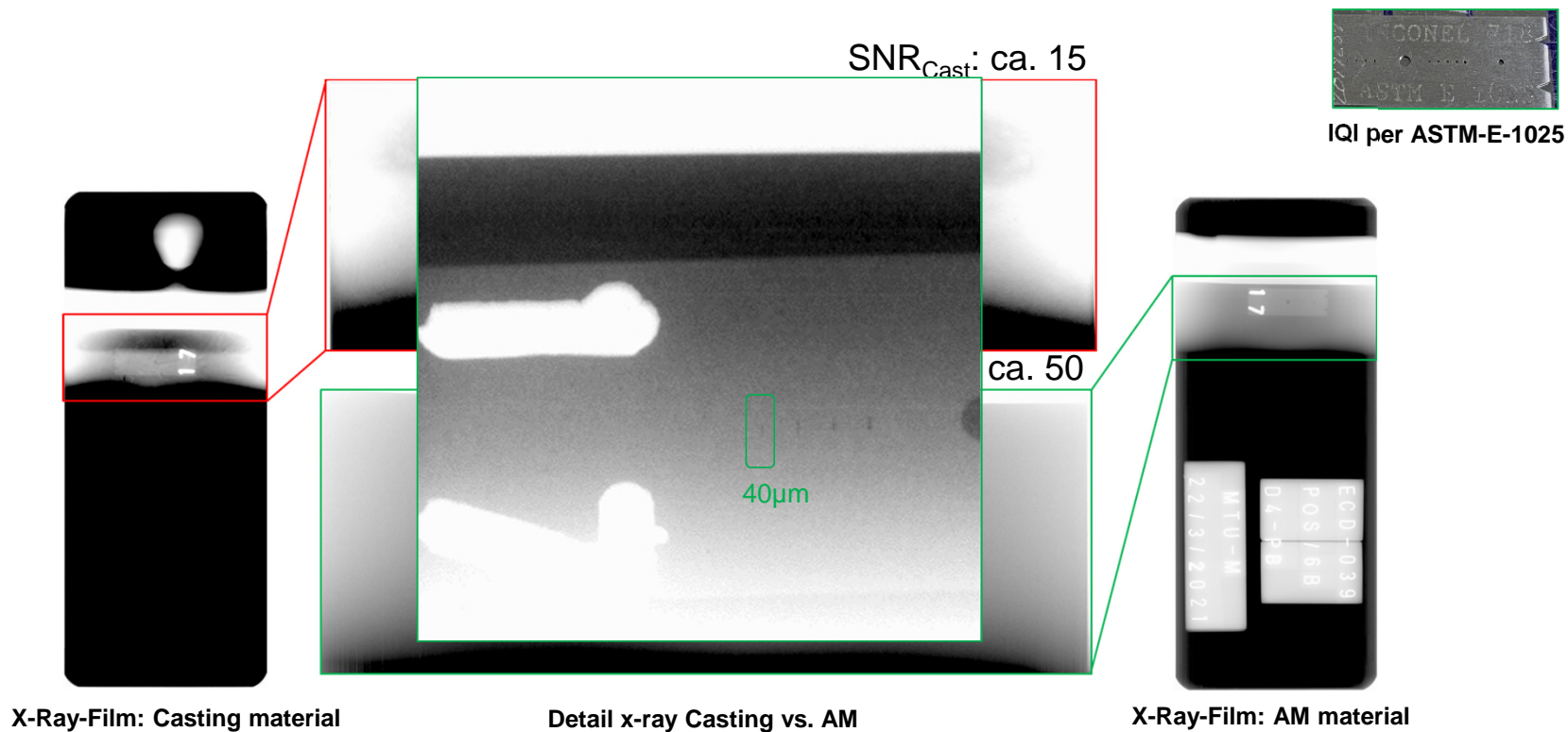


avg. opening: 0.058mm

xy-projection: 0.165mm²

Detectability of IQI vs. “real” AM defect are comparable. Any correction / knock down factor needed?

Manufacturing Method @ MTU – NDI capability (Comparison casting and AM material)



Compared to typical casting microstructure, the additively produced bulk material enables significantly improved detectability of defects using conventional 2D film X-ray technology

Is this a way forward for a future 'Standard'?

- Comments welcome!

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